

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination BUNICK ET AL.
			Examiner Simon J. Oh	Art Unit 1615

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,060,078	05-2000	Lee, Young Won	424/440
B	US-6,139,865	10-2000	Friend et al.	424/441
C	US-			
D	US-			
E	US-			
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I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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P					
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T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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